Substitute for Form 1449A/PTO (Modified)			Attorney Docket No.: 42390P11369	Application Number: Not Yet Assigned							
(use as many sheets as necessary)			First Named Inventor:								
			Chen et al. Filing Date: Concurrently Herewith								
							·		LITERATURE DOCUMENTS		
						Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			lation ²
M		WARREN GROBMAN AND YAO-TING WANG. Practical IC Design in the Subwavelength Regime. Web Page [online]. Integrated System Design Magazine. Posted 01/30/01. [Retrieved on May 25, 2001] Retrieved on the Internet: <url: 1-8.<="" http:="" oeg20010130s0098.="" pages="" story="" td="" www.isdmag.com=""></url:>									
In		Integrated System Design Magazine isdmag.com. Figures 1-4. Web Page [online]. [Retrieved on May 25, 2001] Retrieved on the Internet: <url: 1-4.<="" 2001="" coverstoryfigures0102.html.="" editorial="" http:="" pages="" td="" www.isdmag.com=""></url:>									
000	DR. J. TRACY WEED and DR. LINARD KARKLIN. Dark-Field Double Exposure PSM				· · · · · · · · · · · · · · · · · · ·						
	Technique: A Manufacturing Approach to Phase Shifting. Semiconductors: SubMicron Focus:										
1		Double Exposure. Web Page [online]. Canon U.S.A. Inc. [Retrieved on May 29, 2001]									
Retrieved on the Internet: <url:< td=""><td>adaginavis enringest 4 html Pages</td><td>_0</td><td></td></url:<>			adaginavis enringest 4 html Pages	_0							
http://www.usa.canon.com/indtech/semicondeq/news_springs51_4.html. Pages 1-9. KENJI SAITOH, MASANOBU HASEGAWA, AKIYOSHI SUZUKI and MINOR				ORU YOSHII.							
		IDEAL Way to Extend Optical Lithograph	y. Semiconductors: SubMicron Focu	: Aberrations.							
Web Page [online]. Canon U.S.A. Inc. Internet: <url: http:="" td="" www.usa.canon.<=""><td>trieved on May 29, 2001 Retrieved o</td><td>n the ,</td><td></td></url:>			trieved on May 29, 2001 Retrieved o	n the ,							
				1							
Za.		STAN CHOW, ANDREW B. KAHNG AND MAJID SARRAFZADEH. Modern Physical Design: Algorithm Technology Methodology (Part V). ICCAD Tutorial, November 9, 2000. [online] [Retrieved on June 22, 2001] Retrieved on the Internet: <url: 1-44.<="" http:="" iccad00tutorial="" pages="" part5.pdf.="" td="" www.vlsicad.cs.ucla.edu=""></url:>									
											
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